

DAC016N170ZY3

Silicon Carbide Enhancement Mode MOSFET

Features

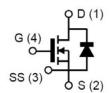
- High blocking voltage with low Rds(on)
- High frequency operation with low Capacitance
- Simple to drive with -4V/+18V gate
- · Robust body diode with low Qrr
- 100% Avalanche Tested

Benefits

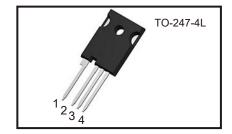
- Superior robustness and system reliability
- Higher system efficiency
- Easier paralleling without thermal runaway
- Capable of high temperature application
- Faster and more efficient switching

Applications

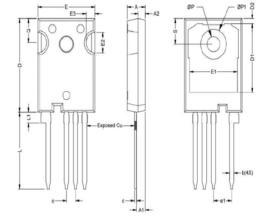
- EV motor drives
- EV/HEV charging station
- Energy storage and Battery charging
- High voltage DC-DC converters
- Solar / Wind Inverters
- UPS and PFC



V_{DSS}	1700V
I _{D(@25°C)}	138A
$R_{DS(ON)typ.}$	16m Ω



Package Dimensions



DIM	MILLIMETERS				
DIM	MIN TYP.		MAX		
Α	4.82	5.02	5.22		
A1	2.21	2.41	2.61		
A2	1.8	2	2.2		
b	0.95	1.2	1.45		
b1	1.95	2.2	2.45		
b2	2.95	3.2	3.45		
С	0.35	0.6	0.85		
D	22.34	22.54	22.74		
D1	16.3	16.55	16.8		
D2	0.99	1.19	1.39		
E	15.74	15.94	16.14		
E1	13.01	13.26	13.51		
E2	4.71	4.91	5.11		
E3	2.26	2.46	2.66		
е		2.54BSC.			
e1	5.08BSC.				
L	18.23	18.48	18.73		
L1	2.35	2.60	2.85		
Р	3.41	3.61	3.81		
P1	6.94	7.19	7.44		
Q	5.59	5.79	5.99		
S	5.97	6.17	6.37		

Absolute Maximum Ratings

(Tc = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit	
Drain-Source Voltage	V _{GS} =0V I _D =100µA	V _{DS}	1700	V
Gate-Source Voltage (dynamic) du	C (f>1 Hz, uty cycle<1%, ulse width<200ns)	V_{GS}	-10/+25	V
Gate-Source Voltage (static)	$V_{\text{GS(op)}}$	-4/+18	V	
L Drain Current-Continuous	18V@ T _C =25°C 18V@ T _C =100°C	I _D	138 100	Α
Pulse Drain Current		I _{D,pulse}	275	Α
Power Dissipation		P_D	575	W
Storage Temperature Range		T _{STG}	-55 to +175	°C
Operating Junction Temperature Range		TJ	-55 to +175	°C
Soldering Temperature		T _L 260		°C
Avalanche Capability, single pulse *	V _{DD} =100V V _{GS} =10V L=2mH	I _{AV}	88	Α
Avalanche Capability, single pulse**	V _{DD} =100V V _{GS} =10V L=2mH	E _{AV}	3700	mJ

^{* 100%} tested in 60% rating

^{** 100%} tested in 36% rating



DAC016N170ZY3

Electrical Characteristics @ Tc =25°C (unless otherwise specified)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
OFF Characteristics					'		'
Drain-Source Breakdown Voltage	BVpss	V _{GS} =0V , I _D =0.1mA		1700	-	-	V
Zero Gate Voltage Drain Current	IDSS	V _{DS} =1700V	TJ =25°C	-	1	100	μА
		V _{GS} = 0V	T」=175℃	-	10	-	
Octo Octobro Legislana Octobro		V _{GS} =18V , V _{DS} =0V	1	-	5	100	nA
Gate-Source Leakage Current	Igss	V _{GS} =-4V , V _{DS} =0V		-100	-5	-	IIA
ON Characteristics	·						
Gate Threshold Voltage ***		V _{DS} = V _{GS} , I _D =30mA	TJ=25℃	2.5	3.1	4.2	V
	V _{GS(th)}		TJ=175℃	-	2.4	-	V
Drain-Source On-State Resistance	RDS(on)	\/oo =19\/ . In =75A	TJ=25°C	-	16	22	mΩ
Diali-Source On-State Nesistance	TXDS(on)	V _{GS} =18V , I _D =75A	TJ=175℃	-	36	-	111122
Transconductance		V _{DS} =20V , I _D =75A	TJ=25°C	-	60	-	s
Transconductance	913	V 03 - 20 V · 10 - 1 0A	T」=175℃	-	58	-	
Internal Gate Resistance	RG(int.)	f=1MHz · I _D =0A		-	0.95	-	Ω
Dynamic Characteristics							
Input Capacitance	Ciss	V _{DS} = 1200V V _{GS} = 0V f = 100kHz V _{AC} = 25mV		-	6400	-	pF
Output Capacitance	Coss			-	180	-	
Reverse Transfer Capacitance	Crss			-	20	-	
Coss Stored Energy	Eoss			-	160	-	μJ
Turn-On Switching Energy	Eon	V_{DS} =1200V $, V_{GS}$ =-4/+18V $. I_D$ =75A $, R_{G(ext)}$ =2.0Ω $. L$ =200μH		-	1800	-	μJ
Turn-Off Switching Energy	Eoff			-	420	-	
Switching Characteristics					'	1	
Turn-On Delay Time	td(on)	V_{DS} = 1200V , V_{GS} = -4/+18V I_{D} = 75A , $R_{G(ext)}$ = 2.0 Ω L=200 μ H		-	26	-	- ns
Rise Time	tr			-	220	-	
Turn-Off Delay Time	td(off)			-	66	-	
Fall Time	tf			-	18	-	-
Total Gate Charge	Qg	V _{DS} =1200V		-	320	-	
Gate to Source Charge	Qgs	V _{GS} =-4/+18V	V _{GS} =-4/+18V		88	-	nC
Gate to Drain Charge	Qgd	ID=75A		-	130	-	
Body Diode Characteristics							
Inverse Diode Forward Voltage		\/ - 4\/ \ \ 50A	TJ=25°C	-	4.2	-	V
Inverse Diode Forward Voltage	VsD	V _G s=-4V , I _{SD} =50A	TJ=175℃	-	3.7	-	V
Continuous Diode Forward Current	Is	V _{GS} =-4V , T _J =25°C		-	120	-	Α
Reverse Recovery Time	Trr	I _{SD} =75A , V _{GS} =-4V		-	29	-	ns
Reverse Recovery Charge	Qrr	V _R =1200V dif/dt=1704 A/μs			460	_	nC
Peak Reverse Recovery Current	Irrm			-	30	-	Α
Thermal Resistance							
Thermal Resistance, Junction-to-Case	Rθ _{JC}			-	0.15	0.18	°C/\

^{***} Turn-off with -5V gate bias is highly recommended

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Fig 1. Output Characteristics, T_J =-40°C

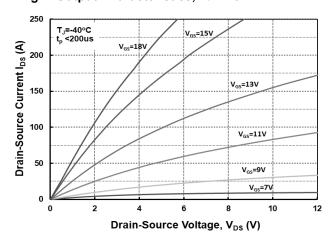


Fig 2. Output Characteristics, T_J =25°C

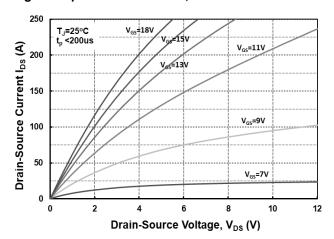


Fig 3. Output Characteristics, T_J =175°C

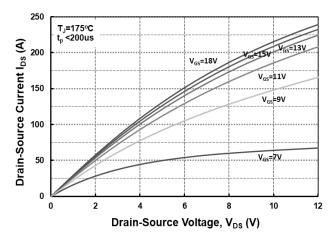


Fig 4. Normalized On-Resistance vs. Temperature

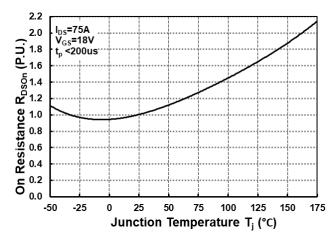


Fig 5. On-Resistance vs. Drain Current for Various Temperatures

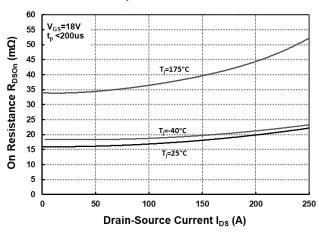
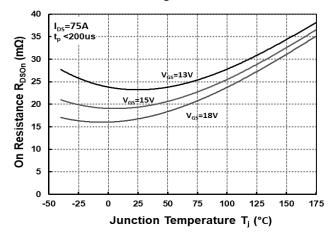


Fig 6. On-Resistance vs. Temperature for Various Gate Voltage



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Fig 7. Transfer Characteristic for Various Junction Temperatures

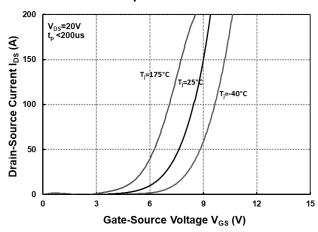


Fig 8. Body Diode Characteristics @ -40°C

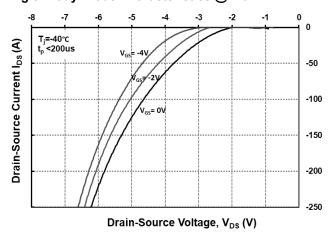


Fig 9. Body Diode Characterisics @ 25°C

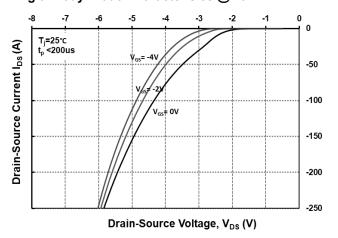


Fig 10. Body Diode Characteristics @ 175°C

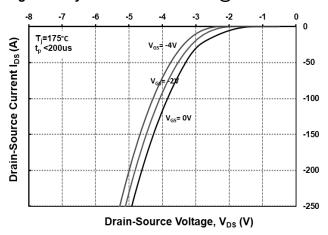


Fig 11. Threshold Voltage vs. Temperature

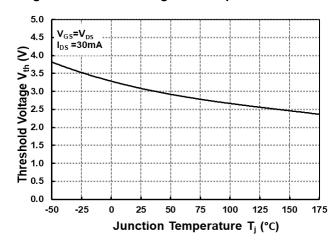


Fig 12. Gate Charge Characteristics

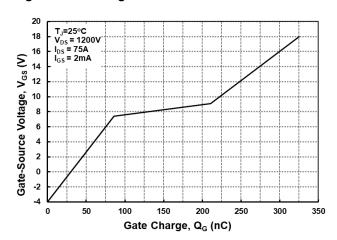




Fig 13. 3rd Quadrant Characteristics @ -40°C

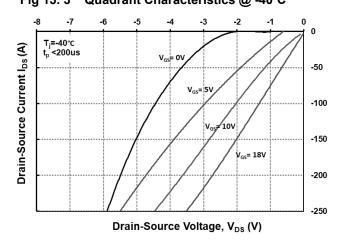


Fig 14. 3rd Quadrant Characteristics @ 25°C

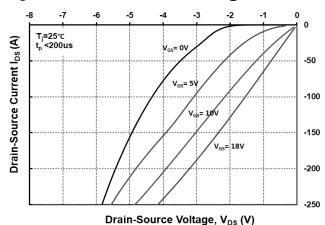


Fig 15. 3rd Quadrant Characteristics @ 175°C

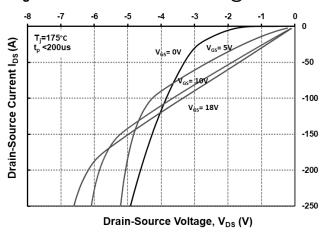


Fig 16. Output Capacitor Stored Energy

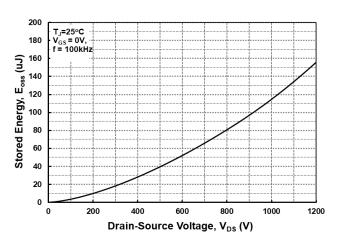


Fig 17. Capacitances vs. Drain-Source Voltage(0-200V)

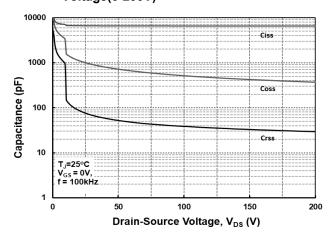
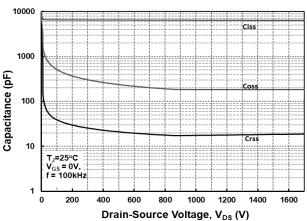


Fig 18. Capacitances vs. Drain-Source Voltage (0-1700V)



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Fig 19. Continuous Drain Current Derating vs.
Case Temperature

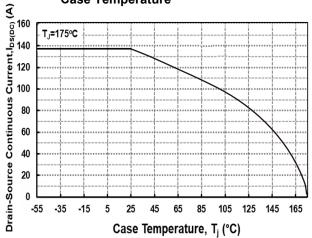


Fig 21. Transient Thermal Impedance (Junction-Case)

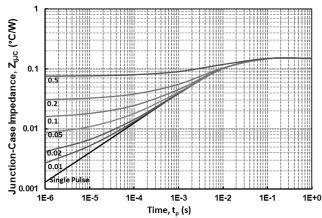


Fig 23. Clamped Inductive Switching Energy vs Drain Current (VDD=800V)

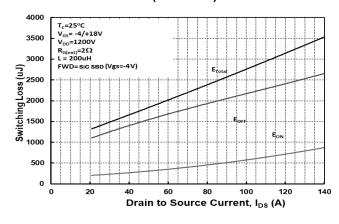


Fig 20. Maximum Power Dissipation Derating vs. Case Temperature

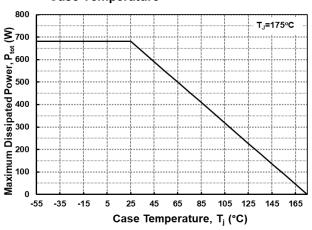


Fig 22. Safe Operating Area

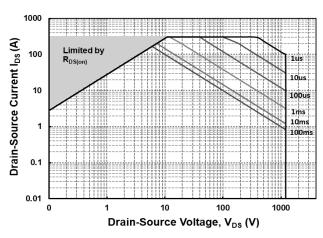
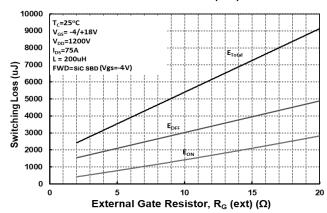


Fig 24. Clamped Inductive Switching Energy vs External Gate Resistor RG(ext)



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Fig 25. Switching Times vs Drain Current V_{DD} =(800V)

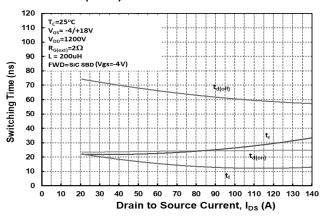
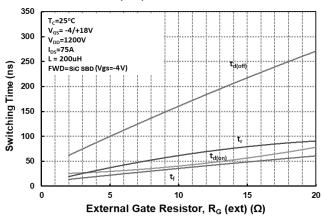


Fig 26. Switching Times vs External Gate Resistor R_G(ext)



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